Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/580,426	MATSUI ET AL.
Examiner Chau N. Nguyen	2831

	SEARCHED					
	OLANOITED					
Class	Subclass	Date	Examiner			
174	113R	2/22/2007	CN			
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174	108	7/18/2007	CN			

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Class	Subclass	Date	Examiner	
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